

Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No.	Application No.:
	ALTRP082	Filed Herewith
	Applicant:	
	Plofsky	
	Filing Date	Group
	Filed Herewith	Unassigned

U.S. Patent Documents

Examine Initial	No.	Patent No. N	Date	Patentee	Class	Sub- class	Filing Date
N/	1	4,696,004	09/22/87	Nakajima			
N/	2	4,788,492	11/29/88	Schubert			
N/	3	4,835,736	07/11/89	Easterday			
N/	4	4,847,612	07/11/89	Kaplinsky			
N/	5	4,873,459	10/10/89	El Gamo et al.			
	6	5,036,473	07/30/91	Butts et al.			
	7	5,058,114	10/15/91	Kuboki et al.			
	8	5,329,470	07/12/94	Sample et al.			
	9	5,124,588	06/23/92	Baltus et al.			
	10	5,365,165	11/15/94	El-Ayat et al.			
	11	5,425,036	06/13/95	Liu et al.			
	12	5,452,231	09/19/95	Butts et al.			
	13	5,568,437	10/22/96	Jamal			
	14	5,572,712	11/05/96	Jamal			
	15	5,629,617	05/13/97	Uhling et al.			
	16	5,640,542	06/17/97	Whitsel et al.			
	17	5,661,662	08/26/97	Butts et al.			
	18	5,717,695	02/10/98	Manela et al.			
	19	5,717,699	02/10/98	Haag et al.			
	20	5,764,079	06/98/98	Patel et al.			
	21	5,821,771	10/13/98	Patel et al.			
	22	5,870,410	02/09/99	Norman et al.			
	23	5,960,191	09/28/99	Sample et al.			
	24	5,983,277	11/09/99	Heile et al.			
	25	6,14,334	01/11/00	Patel et al.			
	26	6,016,563	01/18/00	Fleisher			
	27	6,020,758	02/01/00	Patel et al.			
	28	6,104,211	08/15/00	Alfke			
	29	6,157,210	12/05/00	Zaveri et al.			
N/	30	6,182,247	01/30/01	Herrmann et al.			
N/	31	6,212,650	04/03/01	Alfke			
N/	32	6,223,148	04/24/01	Stewart et al.			

Examiner Initial	No.	Patent No. N	Date	Patentee	Class	Sub-class	Filing Date
N/	33	6,247,147	06/12/01	Beenstra et al.			
N/	34	6,286,114	09/04/01	Veenstra et al.			
N/	35	6,317,860	11/13/01	Heile			
N/	36	6,321,369	11/20/01	Heile et al.			
N/	37	6,389,558	05/14/02	Herrmann et al.			
N/	38	6,460,148	01/10/02	Veenstra et al.			
N/	39	6,259,271	07/10/01	Couts-Martin et al.			

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
N/	A	4042262	07/1992	DE				

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
N/	1	Marantz, Joshua, "Enhanced Visibility and Performance in Functional Verification by Reconstruction", Proceedings of the 35 th Annual Conference on Design Automation Conference, Pgs. 164-169. 1998.
	2	Stroud, Charles et al., "Evaluation of FPGA Resources for Built-in Self-test of Programmable Logic Blocks", Proceedings of the 1996 ACM 4 th International Symposium on Field-programmable Gate Arrays, Pg. 107. 1996.
	3	Collins, Robert R., "Overview of Pentium Probe Mode", (www.x86.org/articles/problem/ProbeMode.htm), August 21, 1998, 3 pgs. ✓
	4	Collins, Robert R., "ICE Mode and the Pentium Processor", (www.x86.org/ddj/Nov97/Nov97.htm), August 21, 1986, 6 Pgs. ✓
	5	"PentiumPro Family Developer's Manual", Volum 1: Specifications, Intel®Corporation, 1996, 9 Pgs. ✓
	6	"Pentium® Processor User's Manual", Volume 1, Intel®Corporation, 1993, Pgs. 3-11.
N/	7	Xilinx, Inc.; ISE Logic Design Tools: ChipScope ✓

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
NI	8	Synplicity, Inc. "Identify TM RTL Debugger" 2003; Pg 1-2.
NI	9	Altera, "SignalTap Analysis in the Quartus II Software Version 2.0; September 2002, ver. 2.1; Altera Corporation.
Examiner <i>Nadeem Iqbal</i>		Date Considered <i>4.12.06</i>

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



Form 1449 (Modified) Information Disclosure Statement By Applicant (Use Several Sheets if Necessary)	Atty Docket No. ALTRP082	Application No.: 10/629,508
	Applicant: Plosky, Jordan	Group Unknown
	Filing Date July 29, 2003	

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
N	1	6,107,821	08/22/00	Kelem et al.			

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
N	10	Praveen K. Jaini and Nur A. Touba; "Observing Test Response of Embedded Cores through Surround Logic"; 1999 IEEE.
N	11	Nur A. Touba and Bahram Pouya; "Testing Embedded Cores Using Partial Isolation Rings"; 1997 IEEE.
Examiner <i>Nadeem Iqbal</i>		Date Considered <i>4-12-06</i>

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Form 1449 (Modified)	Atty Docket No. ALTRP082	Application No.: 10/629,508
Information Disclosure Statement By Applicant	Applicant: Plofsky, Jordan	
(Use Several Sheets if Necessary)	Filing Date July 29, 2003	Group 2113

U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
N/	A.	5,425,036	06/13/1995	Liu et al.			
N/	B.	5,157,781	10/20/1992	Harwood et al.			
N/	C.	4,835,736	05/30/1989	Easterday			
N/	D.	4,527,234	07/02/1985	Bellay			

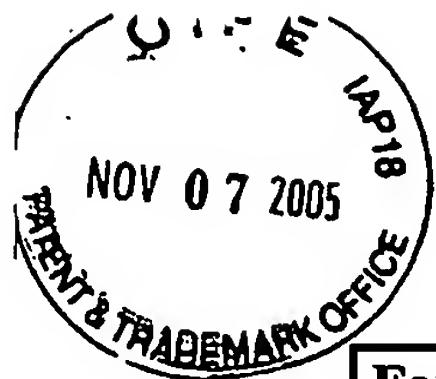
Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No
N/	E.	EP 0 762 279 A1	03/12/1997	EPO			X	

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
Examiner	<i>Nadeem Iqbal</i>	Date Considered 4-12-06

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U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub- class	Filing Date
N/	1.	6,481,000	06/29/2000	Zaveri et al.			
N/	2.	6,704,889	08/06/2002	Veenstra et al.			
	3.	6,754,862	03/09/2001	Hoyer et al.			
	4.	6,794,896	04/21/2003	Brebner, Gordon J.			
	5.	6,891,397	04/21/2003	Brebner, Gordon J.			
N/	6.	6,911,841	08/18/2003	Lee et al.			
N/	7.	2003/0110430	12/10/2001	Bailis et al.			

Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub- class	Translation	
							Yes	No

Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
Examiner	Nadeem Z. Plofsky	
	Date Considered	4-12-06

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